

### Absolute Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V <sub>CBO</sub>	50	V
Collector-Emitter Voltage	V <sub>CEO</sub>	45	V
Emitter-Base Voltage	V <sub>EBO</sub>	5.0	V
Collector Current	lc	0.5	А
Peak Collector Current	Ісм	1.0	A
Peak Base Current	I <sub>BM</sub>	200	mA

# Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Power Dissipation	(Note 6)	D	310	mW	
	(Note 7)	7) P <sub>D</sub>	350	ITIVV	
Thermal Resistance, Junction to Ambient	(Note 6)	D	403	°C/W	
	(Note 7)	R <sub>θJA</sub>	357	C/VV	
Thermal Resistance, Junction to Leads	(Note 8)	R <sub>θJL</sub>	350	°C/W	
Operating and Storage Temperature Range		T <sub>J,</sub> T <sub>STG</sub>	-65 to +150	°C	

# ESD Ratings (Note 9)

Characteristic	Symbol	Value	Unit	JEDEC Class
Electrostatic Discharge - Human Body Model	ESD HBM	8,000	V	3B
Electrostatic Discharge - Machine Model	ESD MM	400	V	С

6. For a device mounted on minimum recommended pad layout FR-4 PCB with high coverage of single sided 1oz copper; device is measured under still air Notes: For a device mounted on minimum recommended pad layout FR-4 PCB with high conditions whilst operating in a steady-state.
Same as Note 6, except mounted on 15mm x 15mm 1oz copper.
Thermal resistance from junction to solder-point (at the end of the collector lead).
Refer to JEDEC specification JESD22-A114 and JESD22-A115.



Single Pulse

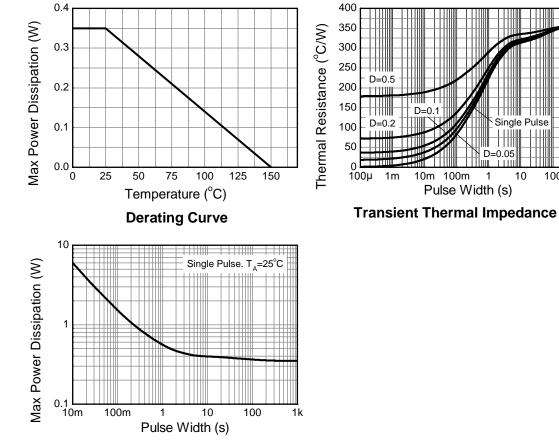
10

100

1k

1.111

# **Thermal Characteristics and Derating Information**



**Pulse Power Dissipation** 



# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
Collector-Base Breakdown Voltage	BV <sub>CBO</sub>	50		—	V	I <sub>C</sub> = 100μA
Collector-Emitter Breakdown Voltage	BV <sub>CEO</sub>	45		—	V	$I_{\rm C} = 10 {\rm mA}$
Emitter-Base Breakdown Voltage	BV <sub>EBO</sub>	5	_	_	V	I <sub>C</sub> = 100μA
Collector-Emitter Cut-Off Current	1	_	—	100	nA	$V_{CE} = 45V$
	ICES			5.0	μA	$V_{CE} = 25V, T_J = +150^{\circ}C$
Emitter-Base Cut-Off Current	I <sub>EBO</sub>	—	_	100	nA	$V_{EB} = 5.0V$
DC Current Gain (Note 10) h <sub>Ft</sub>	h	250		600	600	$V_{CE} = 1.0V, I_{C} = 100mA$
	NFE	<sup>FE</sup> 170	_	_		V <sub>CE</sub> = 1.0V, I <sub>C</sub> = 300mA
Collector-Emitter Saturation Voltage (Note 10)	V <sub>CE(SAT)</sub>	_	_	0.7	V	$I_{\rm C} = 500$ mA, $I_{\rm B} = 50$ mA
Base-Emitter Voltage (Note 10)	V <sub>BE</sub>	_	_	1.2	V	$V_{CE} = 1.0V, I_{C} = 300mA$
Gain Bandwidth Product	fT	100	—	—	MHz	$V_{CE} = 5.0V, I_C = 10mA,$ f = 50MHz
Collector-Base Capacitance	Ссво	_		12	pF	$V_{CB} = 10V, f = 1.0MHz$

Note: 10. Measured under pulsed conditions. Pulse width  $\leq$  300µs. Duty cycle  $\leq$  2%.



#### Typical Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

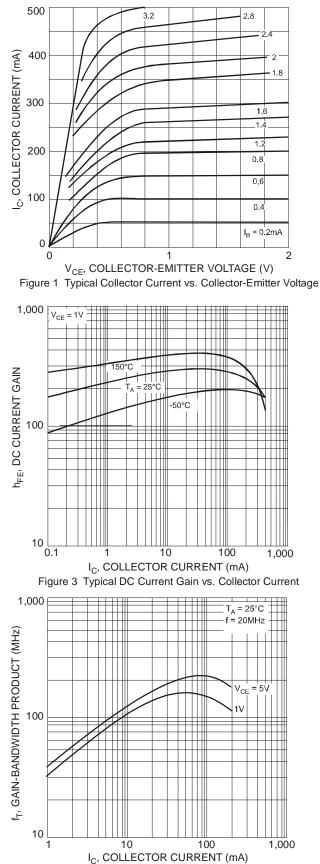
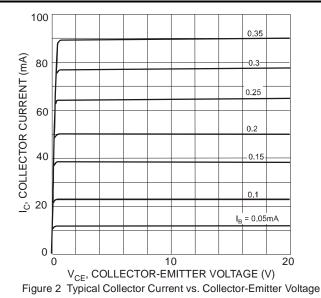
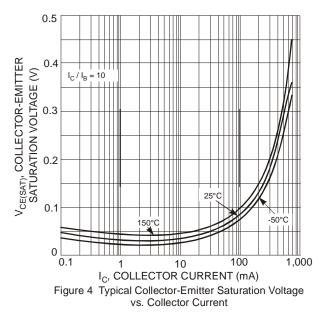


Figure 5 Gain-Bandwidth Product vs. Collector Current





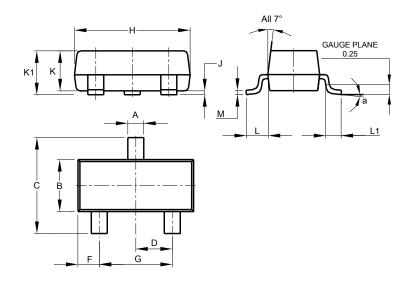


AC817-40Q

### **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

SOT23

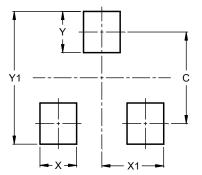


SOT23					
Dim	Min	Max	Тур		
Α	0.37	0.51	0.40		
В	1.20	1.40	1.30		
С	2.30	2.50	2.40		
D	0.89	1.03	0.915		
F	0.45	0.60	0.535		
G	1.78	2.05	1.83		
Η	2.80	3.00	2.90		
J	0.013	0.10	0.05		
Κ	0.890	1.00	0.975		
K1	0.903	1.10	1.025		
L	0.45	0.61	0.55		
L1	0.25	0.55	0.40		
Μ	0.085	0.150	0.110		
а	0°	8°			
All Dimensions in mm					

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

SOT23



Dimensions	Value (in mm)
С	2.0
Х	0.8
X1	1.35
Y	0.9
Y1	2.9



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